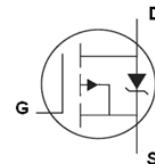
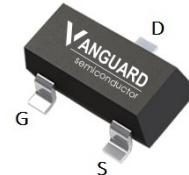


## Features

- P-Channel, -2.5V Logic Level Control
- Enhancement mode
- Fast Switching
- Pb-free lead plating; RoHS compliant

$V_{DS}$	-30	V
$R_{DS(on),TYP} @ V_{GS}=-4.5V$	62	mΩ
$R_{DS(on),TYP} @ V_{GS}=-2.5V$	81	mΩ
$I_D$	-3.8	A

**SOT23-3L**


Part ID	Package Type	Marking	Tape and reel information
VS3401AL	SOT23-3L	VS34	3000pcs/reel

## Maximum ratings, at $T_j = 25^\circ C$ , unless otherwise specified

Symbol	Parameter	Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage	-30	V
$I_s$	Diode continuous forward current	$T_A = 25^\circ C$	A
$I_D$	Continuous drain current @ $V_{GS}=-4.5V$	$T_A = 25^\circ C$	A
		$T_A = 70^\circ C$	A
$I_{DM}$	Pulse drain current tested ①	$T_A = 25^\circ C$	A
$P_D$	Maximum power dissipation	$T_A = 25^\circ C$	W
$V_{GS}$	Gate-Source voltage	±12	V
$T_{STG} T_J$	Storage and operating temperature range	-55 to 150	°C

## Thermal Characteristics

$R_{eJL}$	Thermal Resistance, Junction to Lead	60	°C/W
$R_{eJA}$	Thermal Resistance, Junction to Ambient	100	°C/W

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics @ T<sub>j</sub> = 25°C (unless otherwise stated)</b>						
V <sub>(BR)DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V, I <sub>D</sub> =-250μA	-30	--	--	V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current(T <sub>j</sub> =25°C)	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V	--	--	1	μA
	Zero Gate Voltage Drain Current(T <sub>j</sub> =125°C)	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V	--	--	100	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±12V, V <sub>DS</sub> =0V	--	--	±100	nA
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-0.5	--	-1.2	V
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance②	V <sub>GS</sub> =-10V, I <sub>D</sub> =-4A	--	52	60	mΩ
		V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-3A	--	62	70	mΩ
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-2A	--	81	105	mΩ
<b>Dynamic Electrical Characteristics @ T<sub>j</sub>= 25°C (unless otherwise stated)</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1MHz	700	805	880	pF
C <sub>oss</sub>	Output Capacitance		--	60	110	pF
C <sub>rss</sub>	Reverse Transfer Capacitance		--	45	80	pF
R <sub>g</sub>	Gate Resistance	f=1MHz	--	10	--	Ω
Q <sub>q</sub>	Total Gate Charge	V <sub>DS</sub> =-15V, I <sub>D</sub> =-3A, V <sub>GS</sub> =-4.5V	--	10	--	nC
Q <sub>qs</sub>	Gate-Source Charge		--	2.3	--	nC
Q <sub>qd</sub>	Gate-Drain Charge		--	4.2	--	nC
<b>Switching Characteristics</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =-15 V, I <sub>D</sub> =-3A, R <sub>G</sub> =3Ω, V <sub>GS</sub> =-4.5V	--	4	--	nS
t <sub>r</sub>	Turn-on Rise Time		--	4	--	nS
t <sub>d(off)</sub>	Turn-Off Delay Time		--	28	--	nS
t <sub>f</sub>	Turn-Off Fall Time		--	4.6	--	nS
<b>Source- Drain Diode Characteristics@ T<sub>j</sub>= 25°C (unless otherwise stated)</b>						
V <sub>SD</sub>	Forward on voltage	I <sub>SD</sub> =-3A, V <sub>GS</sub> =0V	--	-0.85	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	T <sub>j</sub> =25°C, I <sub>sd</sub> =-3A, V <sub>GS</sub> =0V di/dt=-100A/μs	--	12	--	nS
Q <sub>rr</sub>	Reverse Recovery Charge			3.6		nC

NOTE:

① Repetitive rating; pulse width limited by max. junction temperature.

② Pulse width ≤ 300μs; duty cycle≤ 2%.



Vanguard  
Semiconductor

VS3401AL

-30V/-3.8A P-Channel Advanced Power MOSFET

## Typical Characteristics

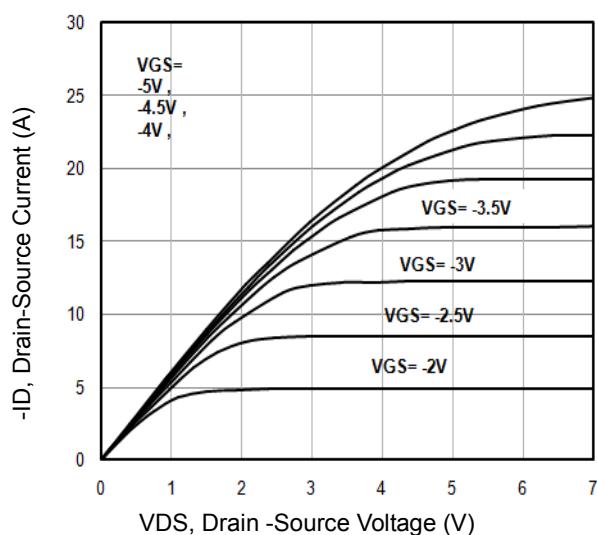


Fig1. Typical Output Characteristics

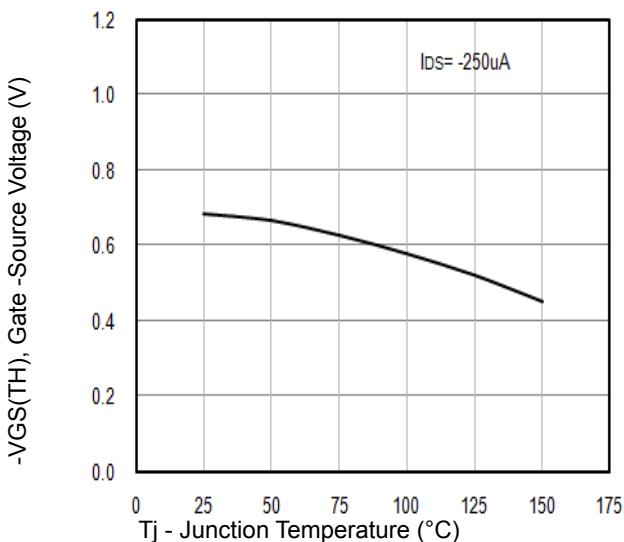


Fig2.  $V_{GS(TH)}$  Gate-Source Voltage Vs.  $T_j$

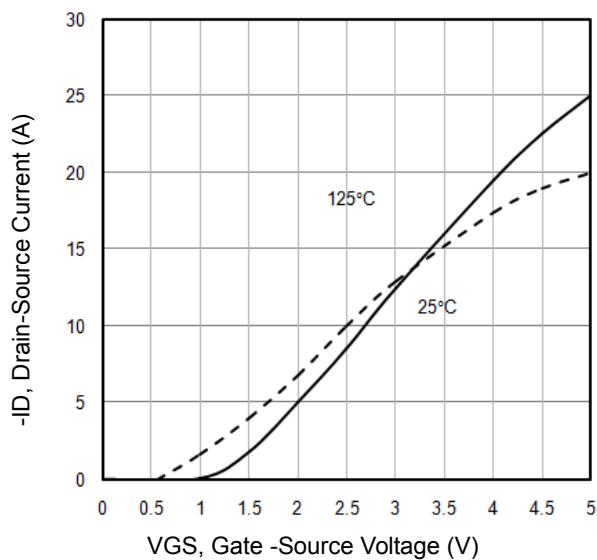


Fig3. Typical Transfer Characteristics

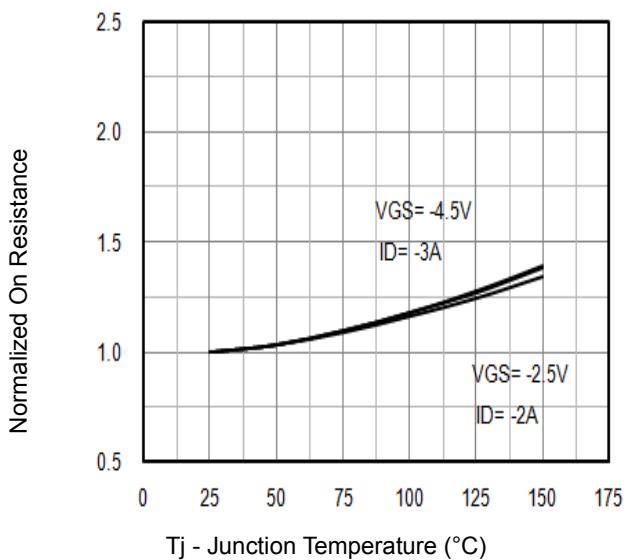


Fig4. Normalized On-Resistance Vs.  $T_j$

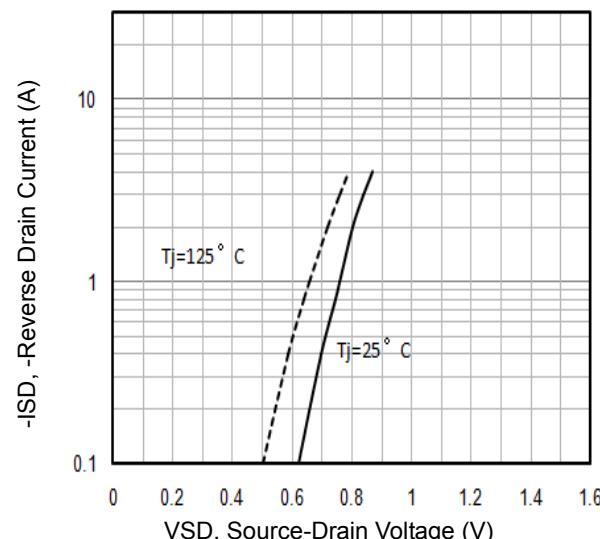


Fig5. Typical Source-Drain Diode Forward Voltage

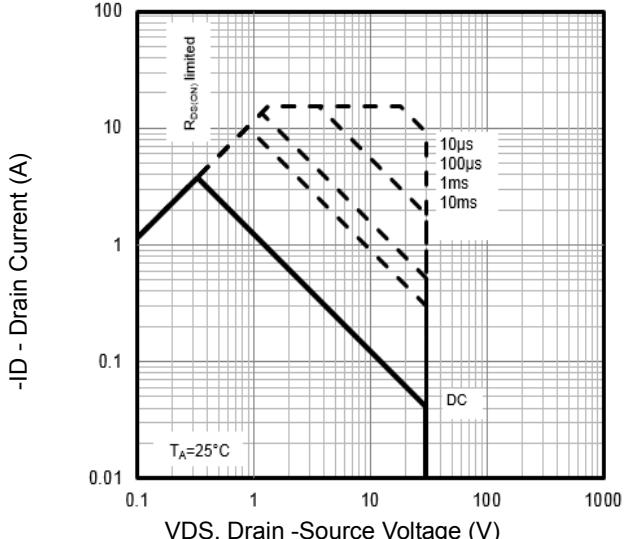


Fig6. Maximum Safe Operating Area



## Typical Characteristics

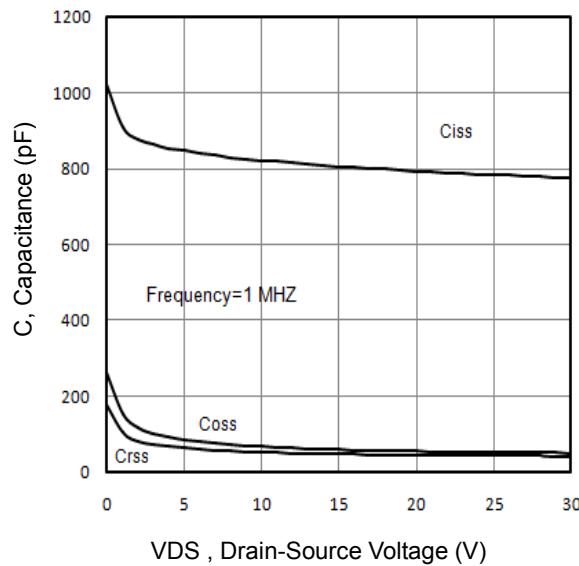


Fig7. Typical Capacitance Vs.Drain-Source Voltage

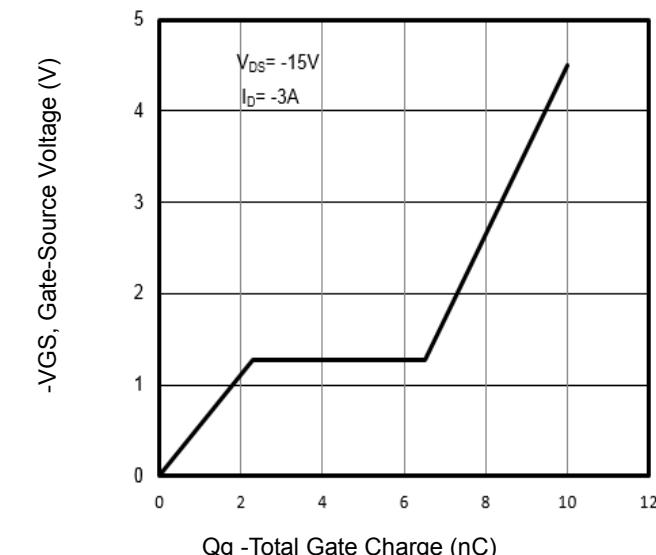


Fig8. Typical Gate Charge Vs.Gate-Source Voltage

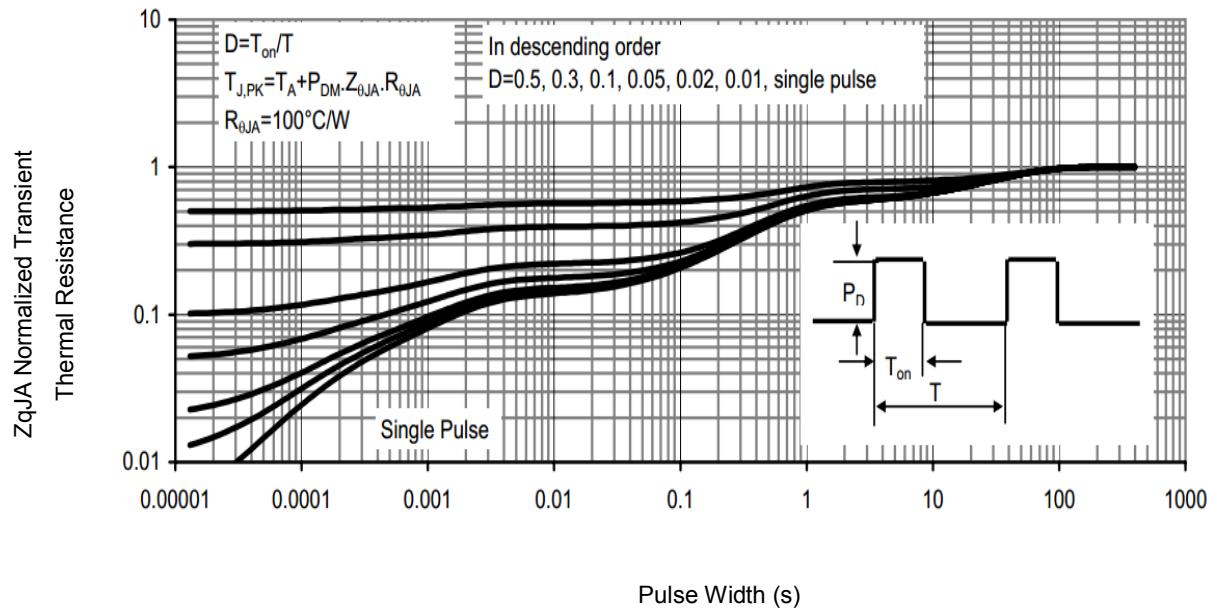


Fig9. Normalized Maximum Transient Thermal Impedance

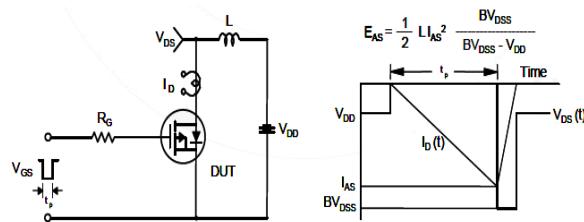


Fig10. Unclamped Inductive Test Circuit and waveforms

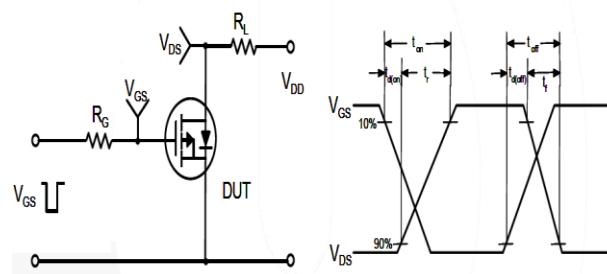
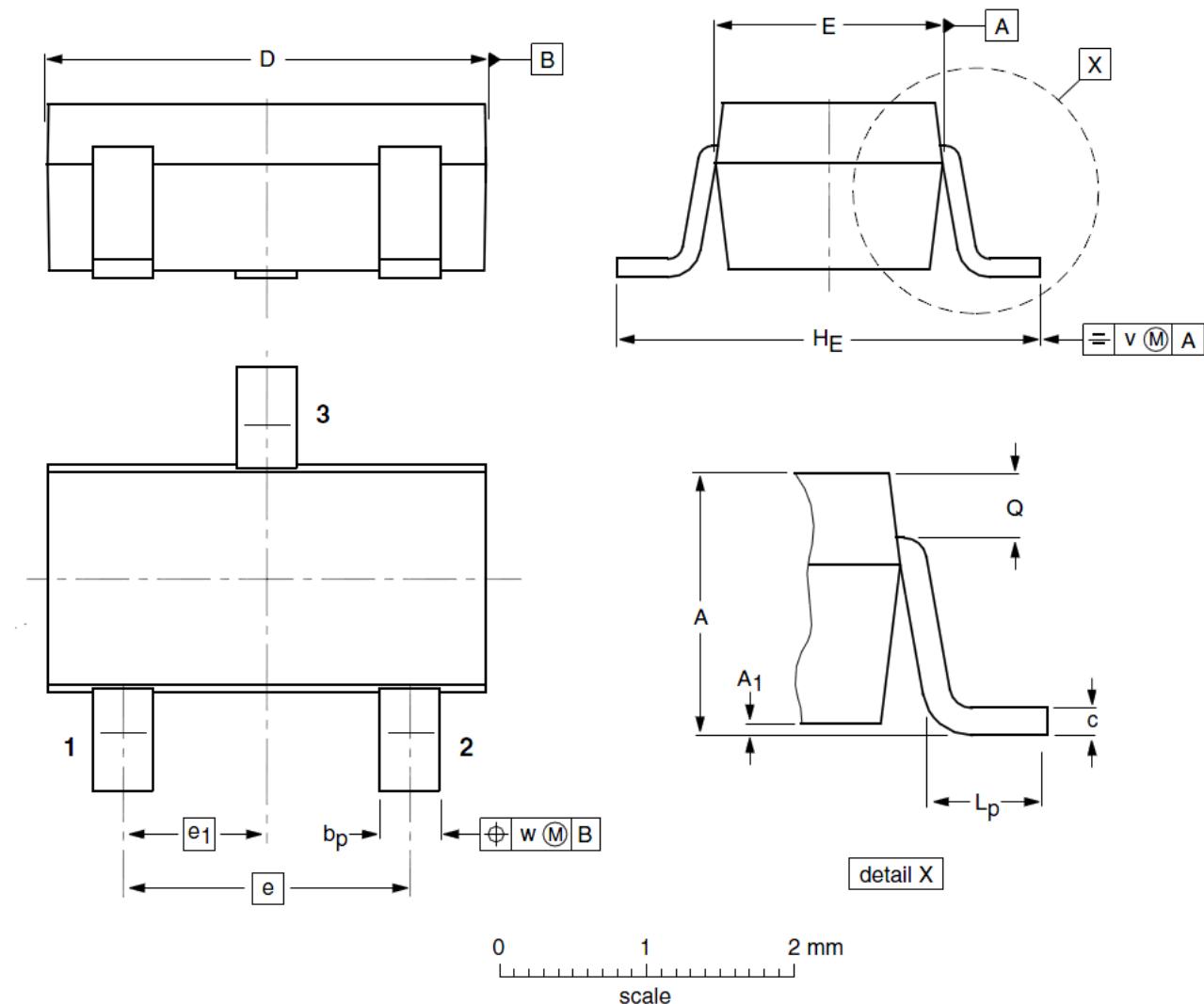


Fig11. Switching Time Test Circuit and waveforms

**SOT23-3L Package Outline Data**


Symbol	Dimensions (unit: mm)		
	Min	Typ	Max
<b>A</b>	0.90	1.07	1.25
<b>A<sub>1</sub></b>	0.01	0.06	0.10
<b>b<sub>p</sub></b>	0.30	0.35	0.50
<b>c</b>	0.10	0.15	0.20
<b>D</b>	2.70	2.92	3.10
<b>E</b>	1.30	1.60	1.70
<b>e</b>	--	1.90	--
<b>e<sub>1</sub></b>	--	0.95	--
<b>H<sub>E</sub></b>	2.50	2.80	3.00
<b>L<sub>p</sub></b>	0.30	0.40	0.60
<b>Q</b>	0.23	0.29	0.33
<b>v</b>	--	0.20	--
<b>w</b>	--	0.20	--

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